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Giant magneto-optical response in H⁺ irradiated Zn_{1-x}Co_xO thin films

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Abstract

Remarkable improvements of the magneto-optical properties of Zn_{1-x}Co_xO thin films were achieved by post-growth hydrogen irradiation at temperatures of 400°C. Hydrogen incorporation increases the magnetic circular dichroism signal resulting in large values of ellipticity and Faraday rotation at room temperature. The hysteretic behavior of the magneto-optical field dependent loops at different sub-bandgap wavelength indicates an intrinsic ferromagnetic regime. A giant Faraday rotation of 3000 deg/cm was observed at 400 nm. Optical, structural and microstructural characterizations pointed out the Zn substitution by Co, ruling out the presence of noticeable Co-related secondary phases down to the nanoscale.

The increased values of saturation magnetization, ellipticity and Faraday rotation have been explained basing on an impurity band close to the conduction band minimum, which is induced by Co-V_O (O vacancies) complexes. A phenomenological model founded on such an impurity band and electronic states induced by other Co-defect complexes in the ZnO energy gap allows a thoroughly novel, fine interpretation of the ellipticity spectra.

1. Introduction

Future nonreciprocal photonic components, exploiting the difference between the original input and the final output of the light in a bidirectional transmission path (optical nonreciprocity), are indispensable components in optical communications systems.¹ The breaking of such bidirectional transmission reciprocity of the light is achieved by using materials exhibiting magneto-optical (MO) effect, able to rotate the polarization plane of the transmitted (reflected) light by the Faraday (Kerr) effect in spectral regions where the optical absorption is negligible.

From the materials point of view, exploring improved MO thin film materials with high figure of merit (i.e. high ratio of Faraday rotation (FR) per unit length to the optical loss per unit length) can pave the way for development of new integrated on-chip nonreciprocal photonic devices, such as optical circulators, isolators and directional amplifiers which are based on the Faraday effect.¹⁻³ Nowadays, garnets are the current material solution for such MO devices due to low optical absorption and extremely high FR of $3-5 \times 10^3$ deg/cm (yttrium iron garnet, YIG) up to 8×10^4 deg/cm (bismuth iron garnet), at 633 nm.³⁻⁵ However, the integration of garnets in optical semiconductor circuits is a challenge due to incompatibility between film deposition and device fabrication processes. First of all, garnets have a complex unit cell structure and much larger lattice parameter compared with semiconductors (YIG: 12.376 Å, Si: 5.43 Å, GaAs: 5.65 Å), which excludes the possibility of hetero-epitaxial growth of garnet films on a conventional semiconductor substrate. Secondly, the thermal expansion coefficient of YIG ($10.4 \times 10^{-6}/^\circ\text{C}$) is much larger than Si ($2.3 \times 10^{-6}/^\circ\text{C}$), GaAs ($5.7 \times 10^{-6}/^\circ\text{C}$), InP ($4.7 \times 10^{-6}/^\circ\text{C}$), ZnO ($5.0 \times 10^{-6}/^\circ\text{C}$): cracks can easily generate in crystallized YIG films on silicon when the thickness exceeds the critical value of about 100 nm.⁶ Thirdly, crystallization of the garnet phase usually requires an annealing treatment at high temperature (700-800 °C): impurity phases such as YFeO_3 , Fe_2O_3 and Bi_2O_3 can precipitate out during the crystallization process, which may cause optical scattering loss in integrated photonic devices. Hence, such factors make the fabrication of high optical quality magnetic garnet films and also optical isolators on semiconductor substrates very difficult.⁷

A promising alternative to garnet films is represented by diluted magnetic semiconductors (DMS) which are a platform for device integration. In such a context, wide gap ZnO-based DMS obtained by incorporating transition metal elements (eg Fe, Co) are suitable for the purpose. In particular, for Co-doped ZnO thin films it has been shown that a large enhancement in the ferromagnetic behavior can be induced by a suitable atomic hydrogen treatment, without the formation of metal Co nanophases.⁸⁻¹¹

In the context of DMS, the MO effect is useful to investigate the strength and the nature of the ferromagnetism as arising from spin polarized carriers magnetically coupled to magnetic ions. However, due to the presence of a finite optical absorption, the polarization of the transmitted light rotates and turns from linear (i.e. superposition of left (LCP) and right (RCP) circularly polarized components) to elliptical. Hence, in general terms the MO effect can be described by a complex rotation whose real and imaginary parts are represented by FR (rotation) and ellipticity (absorption), respectively.

Such quantities provide information about the allowed optical transitions among electronic states at energy E split by the magnetic field, according to the Zeeman effect. The MO effect was previously observed in Co-doped ZnO films mainly at low temperatures.¹¹⁻¹³ There are also reports of MCD at room temperature with hysteretic behavior at the band edge¹⁴ and measurements of MCD after the exposure to Zn metal vapor in a wide sub-bandgap range.¹⁵ To our knowledge the Faraday effect was not observed in Co-doped ZnO yet, although literature results exist in the case of Ti-doped ZnO for photon energies larger than 3 eV.¹⁴

In this work, the role of hydrogen on the optical and magneto-optical properties of ferromagnetic Co-doped ZnO films has been addressed by measuring the MCD spectra of Co-doped ZnO films irradiated by hydrogen ions. The ferromagnetic nature of the magnetic interaction has been investigated by performing room temperature hysteresis loop exploiting the field dependence of the MO effect at different wavelengths in the sub-bandgap region. For the samples irradiated with high H-dose we also measured FR, which is fundamental for MO device applications, at room temperature and visible-NIR range. Increased values of saturation magnetization, ellipticity and Faraday rotation are observed, which can be explained by the existence of an impurity band close to the conduction band minimum, induced by Co-V_O (O vacancies) complexes, combined with

an increase of negative carriers induced by shallow donors,⁸ that are, in the present case, H-related defects. A phenomenological model founded on such an impurity band and electronic states induced by other Co-defect complexes in the ZnO energy gap allows a thoroughly novel, fine interpretation of the ellipticity spectra.

2. Experimental

Thin ZnO:Co films, hereafter referred to as D0, LD1, LD2, HD1, and HD2 were deposited by pulsed laser deposition using a Nd:YAG laser, operating at $\lambda = 355$ nm, fluence ~ 2 J/cm² and 10 Hz of repetition rate, starting from Zn_{1-x}Co_xO pellets with a nominal Co content, $x=0.05$. These films were grown on optically transparent Al₂O₃ (001) single crystals substrates placed at 5 cm from the target, at 500 °C and 2×10^{-5} mbar O₂ pressure with a growth rate of ca 4 Å/s. The averaged thickness values of D0, HD1, HD2, LD1, LD2 determined by SEM and TEM measurements, are 420, 400, 430, 330, and 330 nm, respectively. Subsequently, films HD1, HD2, LD1, LD2 were irradiated with a beam of hydrogen ions produced by a Kaufman source. Hydrogen diffusion in the sample depth was promoted by maintaining the samples at 400 °C during the hydrogenation process with H-beam exposures ranging from 2 to 5 h. The energy of the H-ions was equal to 100 eV with current densities of the order of tens of μ A/cm². The HD1 and HD2 films were irradiated with a H⁺ dose of 4.5×10^{18} ions/cm² (HD), LD1 and LD2 with 1.5×10^{18} ions/cm² (LD), whereas D0 is the unirradiated film.

XRD measurements were performed on a Bruker D8 Advance diffractometer in Bragg-Brentano geometry using the Cu-K α radiation ($\lambda = 1.5406$ Å), with diffracted intensities collected in a θ - 2θ scan. Scanning electron microscopy (SEM) analysis measurements were performed in a Zeiss SUPRA40 scanning electron microscope equipped with a field emission gun. Samples were observed without any preparation. The thickness of the Zn_{1-x}Co_xO films was measured by vertically mounting the samples on a home-made SEM holder. Transmission electron microscopy (TEM) observations were carried out on a Philips CM200 electron microscope equipped with a LaB₆ filament and operating at 200 kV. For TEM cross-sectional observations, samples were prepared by the conventional thinning procedure consisting of mechanical polishing by grinding papers, diamond pastes, and a dimple grinder. Final thinning was carried out by an ion

beam system (Gatan PIPS) using Ar ions at 5 kV. Field-dependent magnetization measurements were performed at 300 K using a Micro Sense Model-10 VSM magnetometer with a max field of 20 kOe. Room temperature optical transmittance spectra were acquired using a Jasco V670 spectrophotometer. MO properties were investigated by using a home-built apparatus capable to perform measurements in the wavelength range 350 - 850 nm in magnetic circular dichroism configuration and 350 – 850 nm in the Faraday rotation configuration, under magnetic fields up to 1.3 T.¹⁶

3. Results and discussion

3.1 *Structural, Microstructural and magnetic properties*

XRD patterns of the blank substrate as well as patterns of the D0, HD1 and LD1 films, respectively treated with zero (untreated), high and low H-dose, are shown in Figure 1. No major structural change occurs, according to our previous results.⁶ Substrate is Al₂O₃ (001) single crystal, while all films are hexagonal ZnO (zincite). No other phases (metallic Co, Co oxides) were detected. The films show a (001) preferential orientation, with the *c*-axis of the hexagonal lattice perpendicular to the Al₂O₃ substrate. The presence of a single ZnO peak in the XRD pattern suggests a columnar growth of the ZnO grains through the entire film thickness. Peak shape analysis of the XRD patterns allowed obtaining the exact angular position of the ZnO (002) peak, which provides value of the *c* lattice parameter of ZnO. Results show that the *c* lattice parameters of the films are about 0.2-0.4% higher than the nominal value of the ZnO compound reported in the ICDD file (n. 36-1451). Furthermore, the full width at half maximum (FWHM) of the ZnO (002) peak can be used in the Scherrer formula to estimate the average grain size of the films. In this case, due to the columnar growth, the Scherrer formula estimates the average lateral size of the columnar grains forming the entire film. For the ZnO films investigated, the average lateral size of the columnar grains ranges between 40 and 100 nm.

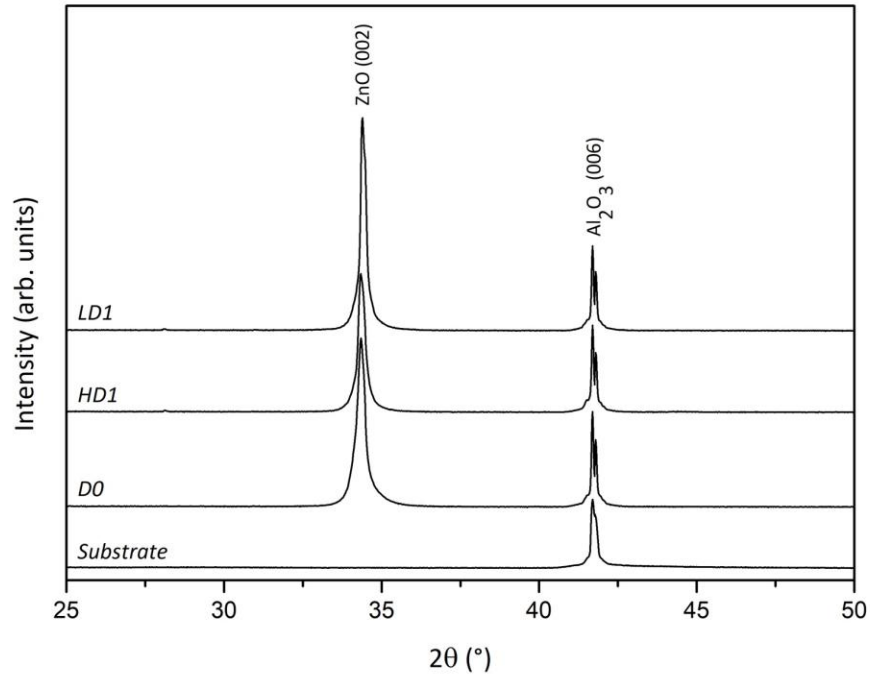


Figure1. XRD patterns of D0, HD1 and LD1 films, treated with zero, high and low H-dose, respectively. Pattern of the blank substrate is also shown. Patterns are vertically shifted for clarity.

Films thickness, morphology, and microstructure were investigated by SEM and TEM analyses. Figure 2a) and 2c) show typical TEM bright field images of the HD2 and LD2 samples respectively. The average thickness of the HD2 film is (430 ± 10) nm while for LD2 average thickness is (330 ± 10) nm. Both films consist of columnar grains having lateral size ranging from 30 to 80 nm. Selected area electron diffraction (SAED) measurements revealed an oriented growth of the ZnO films on the alumina substrate with the following orientation relationships: $[010]_{\text{ZnO}} // [-110]_{\text{Al}_2\text{O}_3}$ and $(001)_{\text{ZnO}} // (001)_{\text{Al}_2\text{O}_3}$, for the HD2 sample, Figure 2b), and $[-110]_{\text{ZnO}} // [-110]_{\text{Al}_2\text{O}_3}$ and $(001)_{\text{ZnO}} // (001)_{\text{Al}_2\text{O}_3}$ for LD2, Figure 2d). The two samples have the c axis perpendicular to the substrate in perfect agreement with the diffraction peaks in XRD spectra.

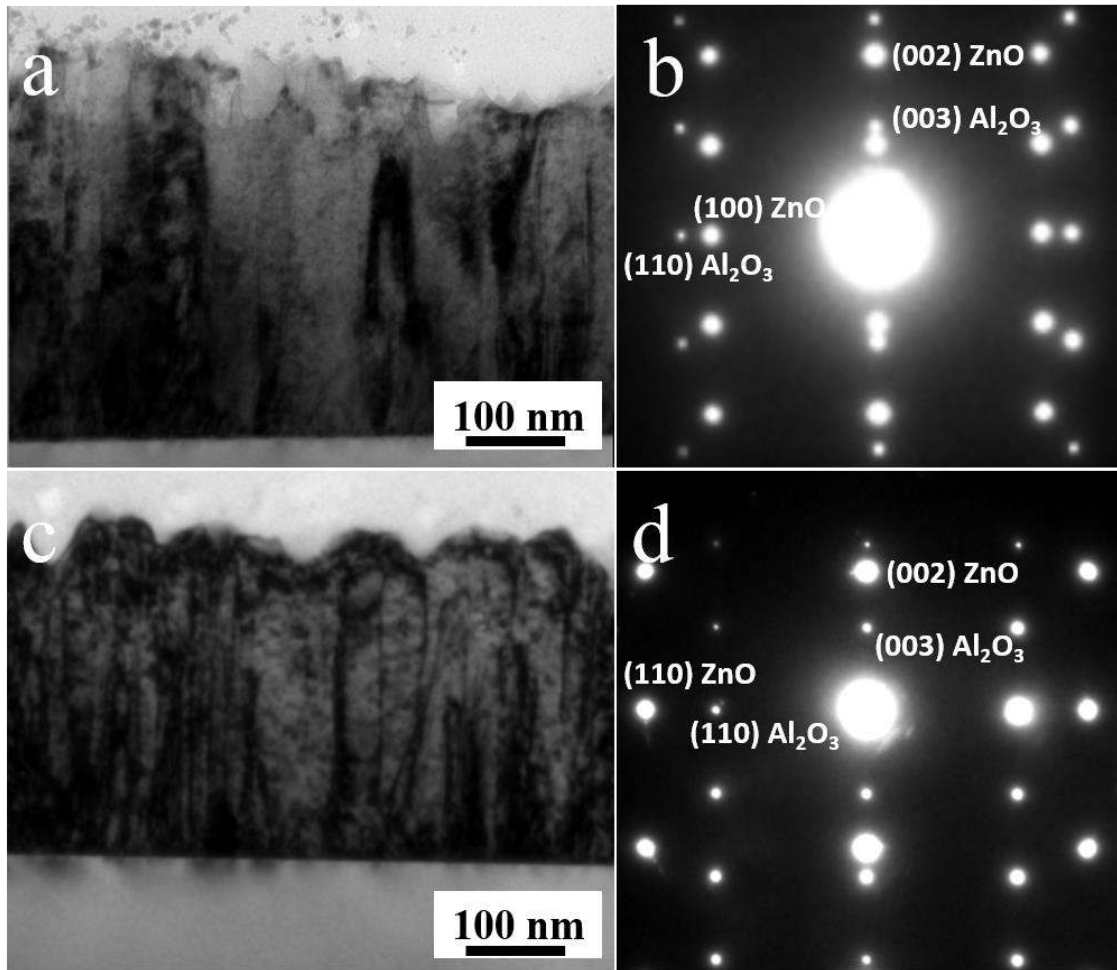


Figure 2. Bright field TEM images and corresponding SAED patterns taken in $[-110]$ Al_2O_3 zone axis of: HD2 (a - b) and LD2 (c - d) samples.

High resolution TEM observations, performed in different areas of the samples, did not reveal the presence of second phase precipitates confirming XRD analysis, albeit crystal defects are present. In particular, Figure 3 shows the typical atomic structure of the $[010]$ ZnO film in the HD2 sample. The atomic order is retained moving from a grain to another and the Fourier analysis of the images (FFT) has never revealed the presence of other phases. The inset of the Figure 3 was obtained removing the noise from the image by using the Gatan Microscopy Suite GMS3 software [<http://www.gatan.com/products/tem-analysis/gatan-microscopy-suite-software>]. The typical approach consists on the FFT of the image, the application of a mask to remove the noise and an inverse FFT to reobtain the image.

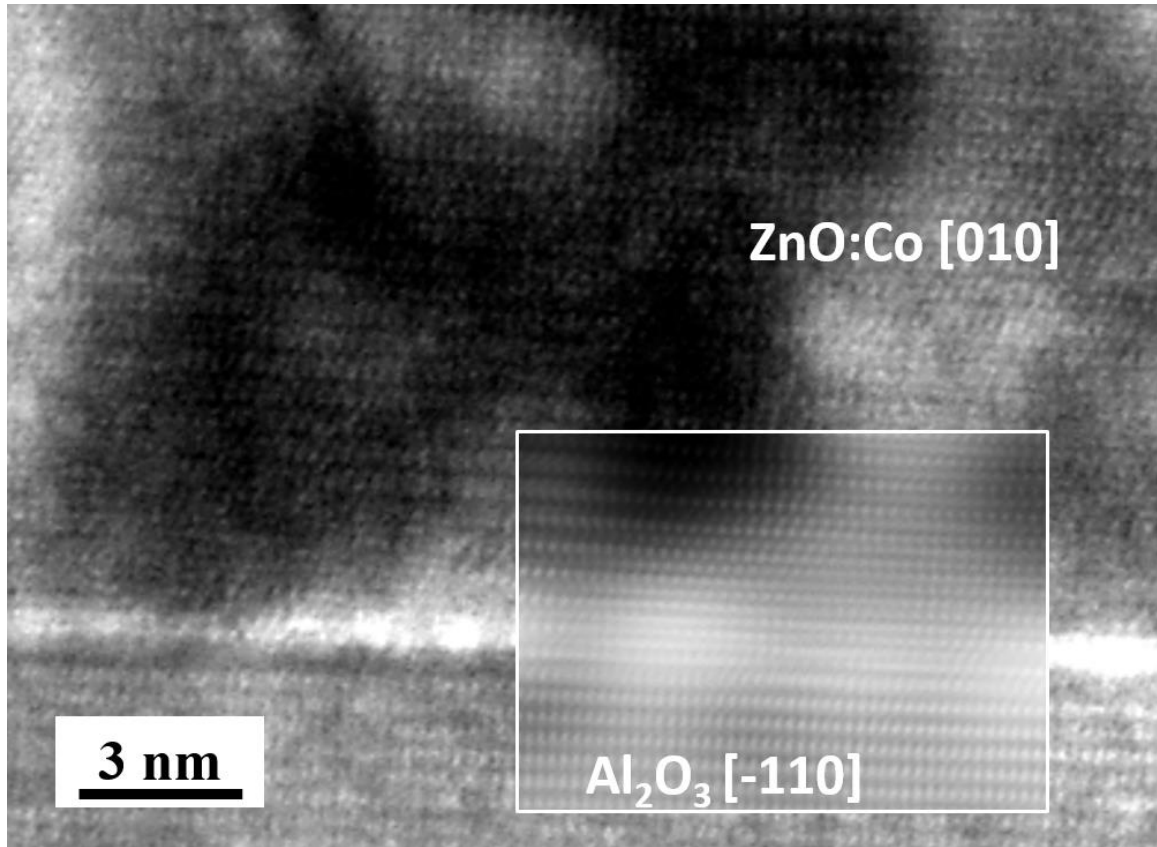


Figure 3. High resolution TEM image of the HD2 sample taken in $[010]_{\text{ZnO}}$ zone axis. The inset was obtained removing the image noise to evidence the sample interface.

The atomic periodicity in the alumina substrate and the film is clearly evidenced in this way, and it is possible to observe the nature of the interface. In detail, the right side of the inset shows that there are zones in which a good match of the lattice cells is present at the interface, but due to the lattice parameters differences, the ZnO cell tends to expand in other zones during the film growth, with the formation of a disordered interface, left side of the inset. The large variation in the image contrast can be attributed to the presence of point defects connected to the Co introduction in the lattice.^{17,18}

Figure 4 shows the field-dependent magnetization loops at $T=300$ K of the samples irradiated with the low and high H-doses. According to our previous results a high H dose can induce large values of the saturation magnetization. Indeed, starting

from saturation magnetization (M_s) values lower than 1 emu/cm^3 for the non-irradiated sample D0, M_s reaches values of $2\text{-}4 \text{ emu/cm}^3$ for LD1 and LD2, and of $10\text{-}12 \text{ emu/cm}^3$ for HD1 and HD2. This large enhancement of M_s supports the results of a previous study⁸ where the ferromagnetic behavior of Co-doped ZnO was attributed to the formation of Co- V_O (oxygen vacancy) complexes and to an increase of the negative carriers induced by shallow donors represented, here, by H-related defects, like H at the V_O site (H_O) and H interstitials (H_I).

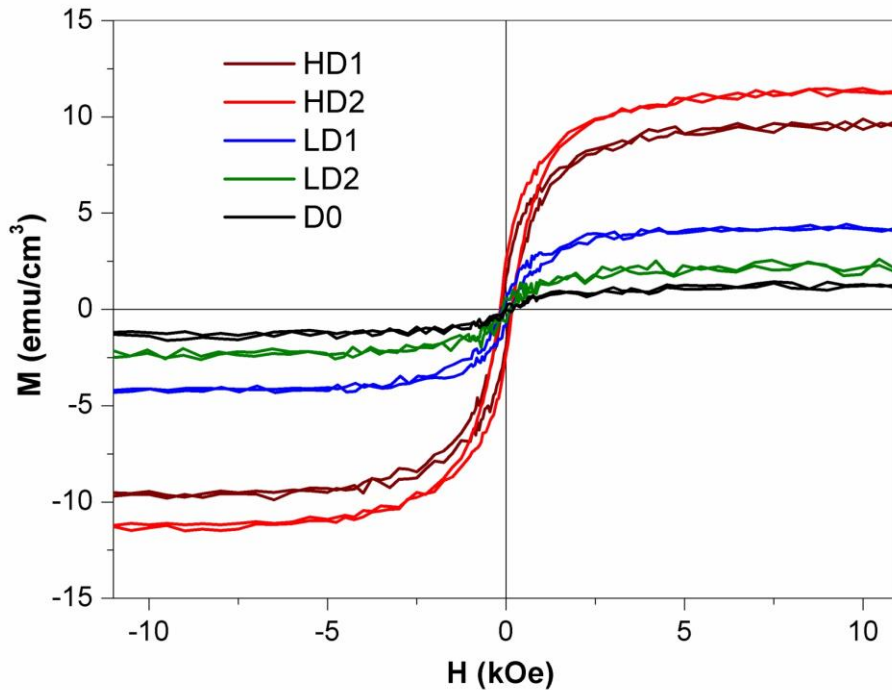


Figure 4. Room temperature hysteresis curves of the zero, low and high H-dose irradiated films.

3.2 Optical and magneto-optical properties

Figure 5 shows the transmittance curves (a) and the MCD spectra, calibrated in degrees (ellipticity) and normalized to the thickness (b), at room temperature and applied field of 1.3 T, of $Zn_{1-x}Co_xO$ films after correction of substrate contribution. MO measurements were focussed on the H-treated films. Both transmittance and ellipticity spectra exhibit a rapid increase near the band edge and a broad positive zone in the visible range up to 850 nm in the NIR region, with some features near 600 nm. All transmission spectra show

absorption dips at about 566, 613, and 660 nm, originating from the ${}^4A_2(F) \rightarrow {}^2A_1(G)$, ${}^4A_2(F) \rightarrow {}^4T_1(P)$, ${}^4A_2(F) \rightarrow {}^2E(G)$ transitions respectively of tetrahedrally coordinated Co^{2+} ions.^{11,19,20} This clearly indicates that the added Co^{2+} ions have substituted Zn^{2+} cations without distorting the wurtzite structure in agreement with the results of the structural characterization.

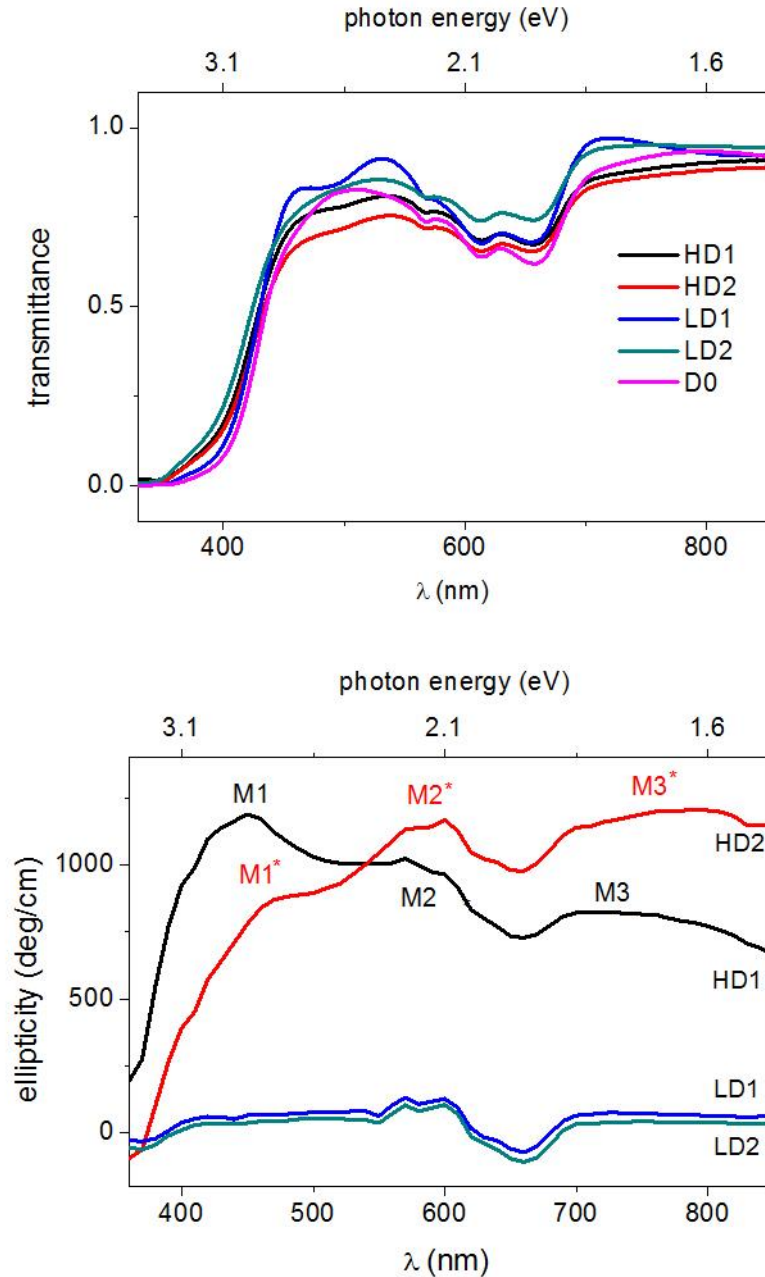


Figure 5. Transmittance (5a, upper panel) and ellipticity spectra (5b, lower panel) of the $Zn_{1-x}Co_xO$ samples (see text).

It is worth noting that, unlike the transmittance curves which are quite independent on the H doping, ellipticity sharply increases on increasing hydrogen content, coherently with the magnetization measurements. In fact, starting from values of about 100 deg/cm for LD1 and LD2 samples, the ellipticity exceeds 1000 deg/cm for the HD1 and HD2 samples in the range 400-600 nm. This large positive value directly indicates that the electronic states involved in the optical transitions are strongly influenced by the magnetic interaction leading to a large level splitting. Hence a large difference in the absorption of LCP and RCP light is expected.

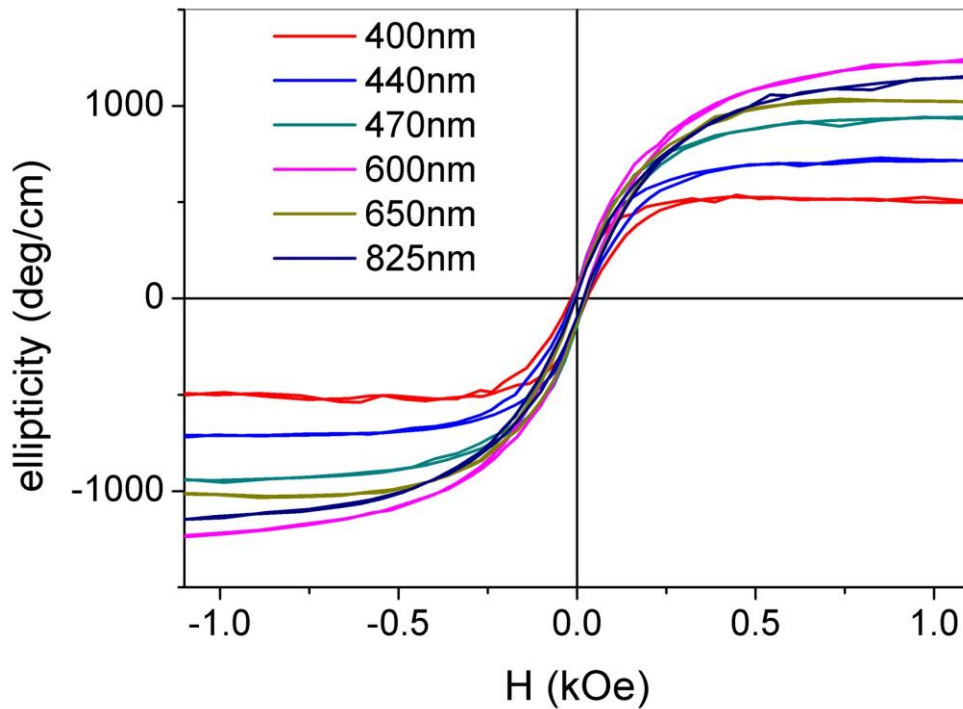


Figure 6. Magneto-optic hysteresis cycles of the HD2 films at room temperature, taken for different sub-bandgap wavelengths, starting from $\lambda=400$ nm.

In order to rule out any paramagnetic character of the ion-carrier interaction we measured the ellipticity as a function of magnetic field for the HD2 sample at different wavelengths, starting from the band edge up to 850 nm, in near-IR region. As shown in Figure 6 all the cycles show a clear ferromagnetic behavior. The curves are hysteretic

with ellipticity values at saturation ranging from 200 up to 1200 deg/cm and coercive fields of about 200 Oe, that well agree with the values of the magnetization measurements. In the sub-bandgap region (λ 400-600 nm), the saturated ellipticity is observed to increase with λ up to 600 nm, where a value of 1200 deg/cm is found, keeping high values except for λ values corresponding to the optical absorption of Co^{2+} ions.

The hysteretic character of the ellipticity curves confirms the intrinsic nature of the ferromagnetic coupling arising from a spin dependent band structure with the interaction between carriers and localized spin of the magnetic ions. In the $\text{Zn}_{1-x}\text{Co}_x\text{O}$ case Co ions cannot sustain magnetic interactions beyond first neighbours,²¹ whereas Co- V_O complexes can promote long-range ferromagnetic order, if additional n doping is present.²¹⁻²³ Accordingly, the strength of the magnetic interaction increases by filling the half-empty donor-like band due to Co- V_O complexes with carriers arising from donor defects.²²⁻²³ Hence the result of higher MCD values for the films treated with high H-doses well agrees with the proposed model as H-irradiation induces additional carriers and favors the formation of V_O defects.⁸

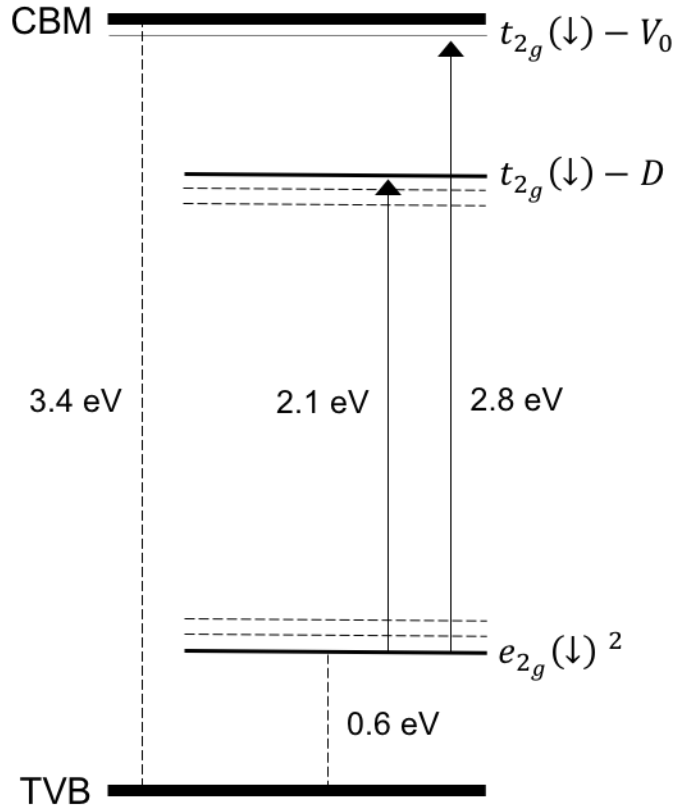


Figure 7. Schematic diagram showing electronic states induced by Co-V_O and Co-D complexes (see the text) in the ZnO energy gap. TVB and CBM indicate the top of the valence band and the conduction band minimum, respectively.

By considering that the ellipticity rapidly increases near the band edge and keeps high values in the sub-bandgap region, we associate the ellipticity values to photoionization transitions involving electronic states induced by Co-defect complexes in the ZnO energy gap.^{15,24}

The HD1 and HD2 ellipticity spectra of Figure 5 (bottom panel) show different shapes characterized by different relative maxima located approximately at 430 nm (2.88 eV), 600 nm (2.10 eV), and in the range of 700-800 nm (1.77-1.55 eV). The fine structures of such spectra can be explained by a phenomenological model founded on previous theoretical studies²⁵ and on a recent Kelvin Probe Force Microscopy (KPFM) investigation of ZnO:Co samples²⁶ giving indications on the levels induced by complexes formed by Co atoms and defects like V_O's in the ZnO electronic structure.

Such levels are schematically reported in Figure 7. The d levels of a Co atom substituting the Zn atom ($3d^7$) are splitted by the crystal field induced by its four O neighbors in filled $e_{2g}(\uparrow)^2$ and $t_{2g}(\uparrow)^3$ majority spin states located in the valence band, a filled $e_{2g}(\downarrow)^2$ minority spin about 0.6 eV above the top of the valence band (TVB), and a $t_{2g}(\downarrow)$ minority spin empty state at about 3 eV above the conduction band minimum (CBM), $t_{2g}(\downarrow)$ -Co, not reported in Figure 7. When a V_O defect and a Co atom form a Co- V_O complex, the $t_{2g}(\downarrow)$ -Co state significantly lowers in energy, about 1.5 eV, since the crystal field is weakened by the removal of an O neighbor. Moreover, when populated by electrons provided by unintentional shallow donors (responsible of the n -type character of as grown ZnO), this $t_{2g}(\downarrow)$ state further descends down to the CBM and partially mix with the CBM itself, $t_{2g}(\downarrow)$ - V_O in Figure 7.²³ Finally, a recent KPFM study shows a significant Fermi level lowering of about 0.4 eV in ZnO:Co, indicating the presence of Co-induced deep levels in the ZnO energy gap. Such levels have been related to the formation of Co-defects (Co-D) complexes enhancing the Co under-coordination already realized in the Co- V_O complex, thus inducing a further lowering of the $t_{2g}(\downarrow)$ state, now indicated as $t_{2g}(\downarrow)$ -D state in Figure 7.²⁶ Then, by disregarding the $t_{2g}(\downarrow)$ -Co state too high in energy, the Co- V_O and Co-D complexes may induce two electronic states close to the CBM and in the energy gap, respectively, that, under illumination with light of suitable wave-length (approximately in the range of 3.0-1.5 eV), become empty or partially occupied and therefore available for internal $d-d$ optical transitions starting from the $e_{2g}(\downarrow)$ filled states common to Co and its complexes.

Let us note that experimental and theoretical results²³ locate the $t_{2g}(\downarrow)$ - V_O state very close to the CBM, whereas the mentioned KPFM results permit to locate the $t_{2g}(\downarrow)$ -D states only quite below the Fermi energy. They are roughly located at 0.7 eV below the CBM in Figure 7. Moreover, the Co-D complex represents a family of complexes where the Co atom undergoes different degrees of under-coordination. This implies a dispersion of these states, as well as of the corresponding $e_{2g}(\downarrow)$ filled states, in a certain range of energy as schematized by the dashed lines in the same figure. Now, a phenomenological interpretation of the HD1 and HD2 ellipticity spectra can be attempted basing on the electronic states sketched in Figure 7 and assuming different relative concentrations of the Co- V_O and Co-D complexes in the HD1 and HD2 samples. In detail, in the high

energy side, the ellipticity signals of the HD1 sample reach a first maximum values M1 at about 430 nm, when the light transmission becomes high ($E < 3$ eV) (the MCD measurement is performed in transmission) and the photon energy corresponds to that required to bring $e_{2g} (\downarrow)$ electrons to the corresponding $t_{2g} (\downarrow)$ - V_O level, about 2.8 eV higher in energy (430 nm). As soon as the energy becomes small for such transitions the ellipticity signals of HD1 decrease and then reaches a second, relative maximum (M2) at about 580 nm, 2.1 eV, that may correspond to transitions $e_{2g} (\downarrow) \rightarrow t_{2g} (\downarrow)$ -D. Then, a further signal decrease is followed by the reaching of a third relative maximum (M3) corresponding to a sort of plateau in the range of 700-800 nm, that is, 0.4-0.6 eV below the M2 peak. This range may still correspond to $e_{2g} (\downarrow) \rightarrow t_{2g} (\downarrow)$ -D once the small dispersion in energy of the $e_{2g} (\downarrow)$ and $t_{2g} (\downarrow)$ -D states, shown in Figure 7, is taken into account. The different amplitudes of the M1, M2, and M3 peaks can be accounted for by a predominant presence of the Co- V_O complexes with respect to the Co-D ones in the HD1 sample. In the case of the HD2, the ellipticity signals show, basically at the same energies of the M1, M2, and M3 maxima, three corresponding, relative maxima M1*, M2*, and M3*. These peaks correspond therefore to the same transitions explaining the HD1 spectrum, while the different MX vs. MX* amplitudes may be accounted for by different relative concentrations of the Co- V_O and Co-D complexes in the two samples, the latter complex being the predominant one in the HD2 sample.

In addition, the ellipticity also receives contributions from the differential absorption in RCP and LCP light at 566, 613, and 660 nm, related to the optical Zeeman-split d^*-d transitions. We observe a broad positive signal ensuing ferromagnetic nature (as it can be observed from the hysteretic behaviour of the curves of Figure 6) although the signal decrease around 600 nm indicates competing contributions to the ellipticity from d^*-d . From the inspection of Figure 5b it can be seen that the ellipticity of the LD1 and LD2 samples around 600 nm takes negative values. This indicates that the main contribution to the ellipticity arises from the optical d^*-d transitions as H-dose and hence the carrier density in LD1 and LD2 are consistently lowered with respect to HD1 and HD2, thus reducing the photoionization.

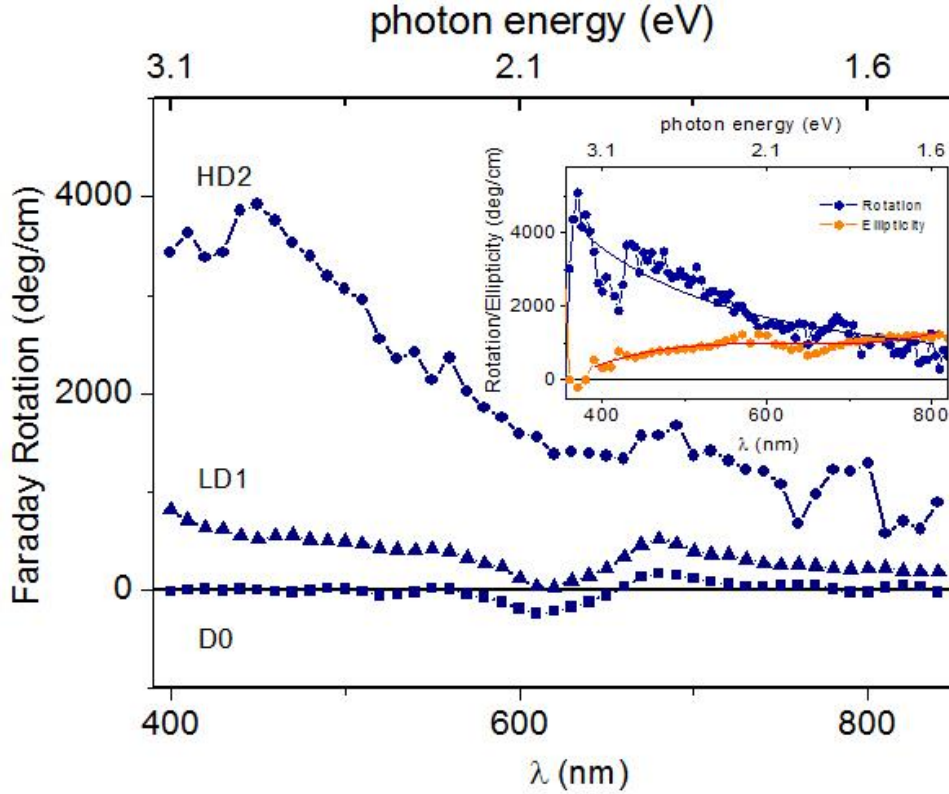


Figure 8. Room temperature Faraday rotation at 1.3 T for unirradiated D0, low (high) H-dose treated sample LD1 (HD2) treated films. Inset: Faraday rotation and ellipticity for the HD2 sample; lines are guide to eye.

To fully investigate the MO response of the H-irradiated $Zn_{1-x}Co_xO$ films we also measured the complex Faraday rotation spectra at saturation (1.3 T) for unirradiated D0, low (high) H-dose treated sample LD1 (HD2). It turns out that the MO response of D0 is quite negligible, whereas LD1 and LD2 exhibit a sizeable effect, reaching a giant values for HD2. This is a further proof of the effectiveness of the H irradiation in modifying the electronic structure of the Co:ZnO and hence of its MO response. Focusing on the HD2 sample both rotation and ellipticity are reported as a function of λ in the inset of Figure 8. The MO response consists of two main regions with different characteristics: a pure rotatory regime from the band edge up to 550 nm, where a rotation of the polarization plane up to 4000 deg/cm is observed around 368 nm which corresponds to the exciton wavelength of ZnO. For $\lambda > 550$ nm the ellipticity reaches its maximum overlapping the rotational value of about 1000 deg/cm. In the last regime the polarization of transmitted

light is rotated and turned from linear to elliptical.

Finally, the efficiency of H-irradiation in producing large enhancements of ellipticity and FR in $Zn_{1-x}Co_xO$ films may be exploited in many technological applications. In particular, it is possible to fabricate MO memories for the information storage by combining the H- irradiation with electron beam lithography deposition of H-opaque masks, with a fully controlled spatial modulation.^{22,23} The giant values of the FR may be indeed exploited in the fabrication of Faraday rotators, optical isolators¹⁻³ and circulators taking advantage of the semiconducting nature of the $Zn_{1-x}Co_xO$ which favours device integration. For this purpose, efforts are needed to improve the film microstructure which is generally responsible of high optical absorption loss leading to low values of the ratio Faraday rotation over optical absorption coefficient which undermines device performance.

Summary and conclusions

The irradiation of $Zn_{1-x}Co_xO$ thin films with high doses of hydrogen ions induces a strong magneto-optical effect with a large enhancement of ellipticity and Faraday rotation at room temperature. Optical and microstructural analyses indicate that Co fully substitutes for Zn ions without noticeable Co-related secondary phases. The enhanced values of saturation magnetization, hysteretic ellipticity and Faraday rotation, confirm the intrinsic nature of the ferromagnetism arising from interaction of magnetic ions and carriers in a partially filled donor-like band realized by the concurrent presence of Co-oxygen vacancies complexes and carriers.

Founding on recent theoretical and experimental results giving indications on electronic states induced by Co-defect complexes in the ZnO energy gap, a phenomenological model is proposed which permits a thoroughly new, fine interpretation of the electronic transitions at the base of the ellipticity spectra.

Finally, the values of the Faraday rotation/ellipticity of the hydrogenated films in the *visible* range can be tuned by a suitable choice of the H dose and are promising in the perspective of non-reciprocal magneto-optical devices integrated on semiconductors and, generally speaking, for opto-spintronics devices.²⁹

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